Application/Control No. Applicant(s)/Patent Under Reexamination 10/664,012 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 3726 Marc Jimenez **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2002/0002921 01-2002 101/376 Α Hoffmann et al. В US-С US-US-D Ε US-US-F G US-US-Н USı US-J Κ US-US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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